

Search Notes

Application No.

09/967,299

Examiner

Gordon J Stock

Applicant(s)

CARPI ET AL.

Art Unit

2877

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 356 | 399-401 | 4/28/2004 | GJS |
| 356 | 388,614 | 4/28/2004 | GJS |
| 250 | 492.1 | 4/28/2004 | GJS |
| 250 | 491.1 | 4/28/2004 | GJS |
| 250 | 548 | 4/28/2004 | GJS |
| 250 | 559.29 | 4/28/2004 | GJS |
| 250 | 559.3 | 4/28/2004 | GJS |
| 250 | 559.36 | 4/28/2004 | GJS |
| 355 | 53,55 | 4/28/2004 | GJS |
| 355 | 67,77 | 4/28/2004 | GJS |
| 430 | 5,22,30 | 4/28/2004 | GJS |
| 382 | 151 | 4/28/2004 | GJS |
| 438 | 401 | 4/28/2004 | GJS |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 356 | 401 | 4/28/2004 | GJS |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| update EAST search | 4/28/2004 | GJS |
| NPL: IEEEExplore using: align\$ and spot; (align\$ and beam) and (wafer and mark) | 4/29/2004 | GJS |
| NPL: INSPEC using: (align\$ same (beam or spot)) and (wafer same mark) | 4/29/2004 | GJS |
| update EAST search w/inventor search | 4/29/2004 | GJS |
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